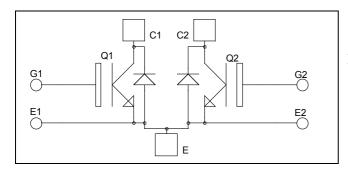
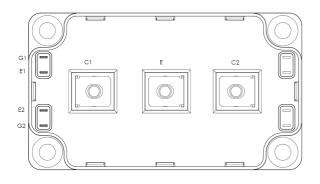


## Dual common source NPT IGBT Power Module





## $V_{CES} = 600V$ $I_{C} = 350A$ @ Tc = 80°C

#### Application

- AC Switches
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

#### Features

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
    - Low tail current
  - Switching frequency up to 100 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
  - Kelvin emitter for easy drive
- Very low stray inductance
  - Symmetrical design
  - M5 power connectors
- High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS compliant

### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		600	V
т	Continuous Collector Current	$T_c = 25^{\circ}C$	430	
I <sub>C</sub>	Continuous Conector Current	$T_c = 80^{\circ}C$	350	А
I <sub>CM</sub>	Pulsed Collector Current	$T_c = 25^{\circ}C$	1225	
V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_c = 25^{\circ}C$	1562	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^{\circ}C$	800A @ 600V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



## All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25^{\circ}C$			200	۸
		$V_{CE} = 600 V$	$T_j = 125^{\circ}C$			1750	μA
V <sub>CE(sat)</sub>	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		2.0	2.5	V
		$I_{\rm C} = 360 {\rm A}$ $T_{\rm j} = 125^{\circ}$	$T_{j} = 125^{\circ}C$		2.2		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 4mA$		3		5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = \pm 20 V, V_{CE} = 0 V$				±300	nA

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		17.2		
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 25V$		1.88		nF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1 MHz		1.6		
Qg	Total gate Charge	$V_{GE} = 15V$		1320		
Q <sub>ge</sub>	Gate – Emitter Charge	$V_{Bus} = 300V$		1160		nC
Q <sub>gc</sub>	Gate – Collector Charge	$I_{\rm C} = 360 {\rm A}$		800		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		26		
Tr	Rise Time	$V_{GE} = 15V$		25		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_{C} = 360A$		150		ns
$T_{f}$	Fall Time	$R_G = 1.25\Omega$		30		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C)		26		
T <sub>r</sub>	Rise Time	$V_{GE} = 15V$		25		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_{C} = 360A$		170		ns
$T_{\rm f}$	Fall Time	$R_G = 1.25\Omega$		40		
Eon	Turn-on Switching Energy			17.2		mJ
E <sub>off</sub>	Turn-off Switching Energy	$ \begin{array}{c} I_{C} = 360 A \\ R_{G} = 1.25 \Omega \end{array}  T_{j} = 125^{\circ} C \\ \end{array} $		14		1113

### **Diode ratings and characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V
T	Maximum Davanza Laskaga Cumant	V <sub>R</sub> =600V	$T_j = 25^{\circ}C$			750	۸
I <sub>RM</sub>	Maximum Reverse Leakage Current		$T_{j} = 125^{\circ}C$			1500	500 µA
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		400		А
	Diode Forward Voltage	$I_{\rm F} = 400 {\rm A}$			1.6	1.8	
$V_{\rm F}$		$I_F = 800A$			1.9		V
		$I_{\rm F} = 400 {\rm A}$	$T_j = 125^{\circ}C$		1.4		
t <sub>rr</sub>	Reverse Recovery Time		$T_j = 25^{\circ}C$		180		ns
۹rr	Reverse Recovery Time	$I_{\rm F} = 400 \text{A}$ $V_{\rm R} = 400 \text{V}$	$T_{j} = 125^{\circ}C$		220		115
Q <sub>rr</sub>	Reverse Recovery Charge	$di/dt = 800 \text{A}/\mu \text{s}$	$T_j = 25^{\circ}C$		1560		nC
	Reverse Receivery charge		$T_{j} = 125^{\circ}C$		5800		ne

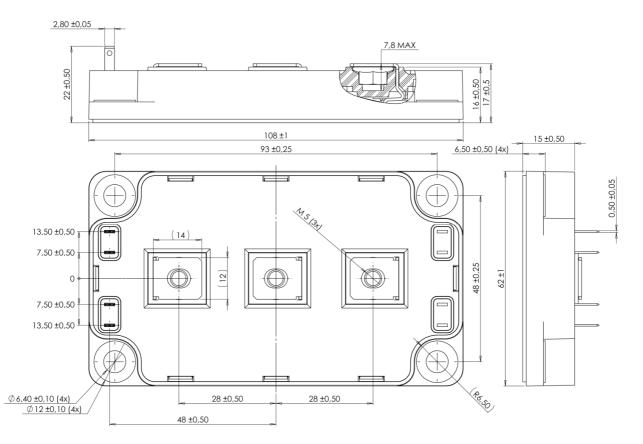
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### Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance		IGBT			0.08	°C/W
<b>R</b> <sub>thJC</sub>			Diode			0.16	C/ W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
TJ	Operating junction temperature range			-40		150	
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M6	3		5	N.m
		For terminals	M5	2		3.5	19.111
Wt	Package Weight					300	g

#### SP6 Package outline (dimensions in mm)

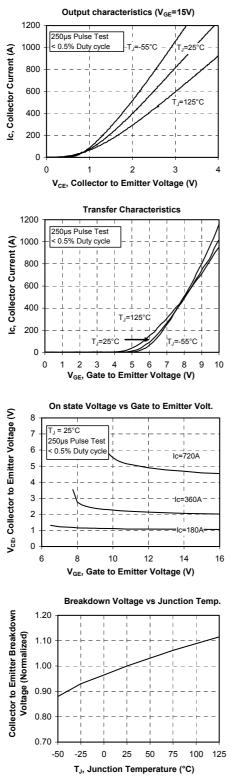


See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

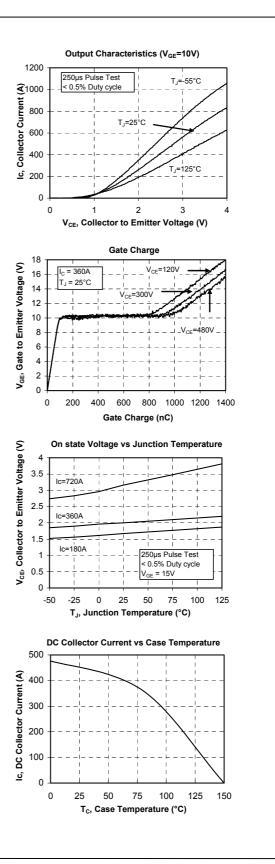
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#### **Typical Performance Curve**



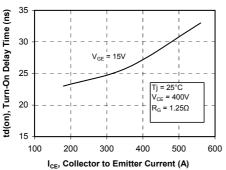
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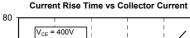


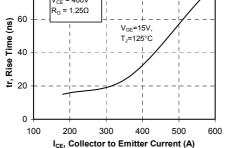
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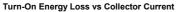


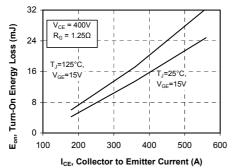
Turn-On Delay Time vs Collector Current

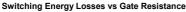


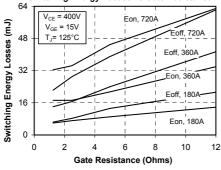




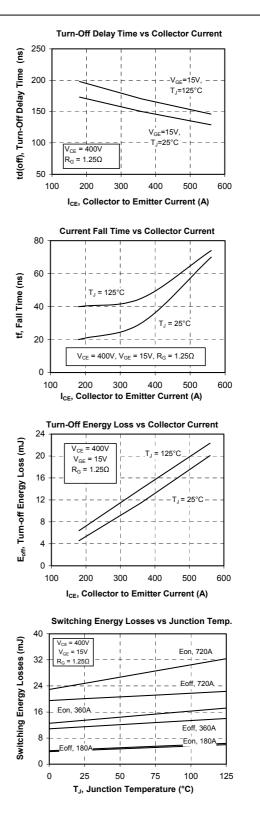




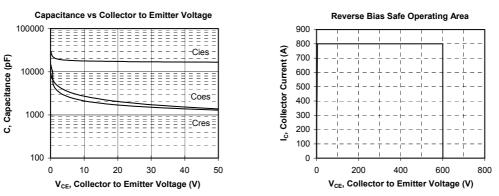




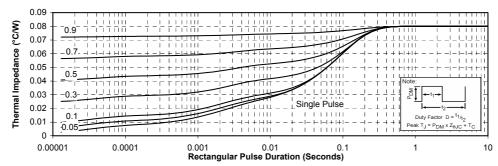
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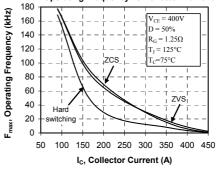




Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



**Operating Frequency vs Collector Current** 





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